Special Issue

Sensor Techniques for Artworks Analysis and Investigations

Message from the Guest Editor

This Special Edition of the journal Sensors is focused on original research involving the use of sensor techniques to study works of art and manuscripts. Topics include but are not limited to:

- reflectance imaging spectroscopy
- mid-Infrared imaging spectroscopy
- X-ray fluorescence imaging spectroscopy
- hyperspectral imaging
- image processing
- 3D imaging
- cultural heritage imaging
- sensors
- artificial intelligence
- machine learning

For more information on the issue, please visit the Special Issue website at:https://www.mdpi.com/si/117850
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Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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